

PSE Technology Corporation

SPECIFICATION FOR APPROVAL

CUSTOMER	
NOMINAL FREQUENCY	32.768 KHz
HOLDER TYPE	TYPE G1 TUNING FORK X'TAL
SPEC. NO. (P/N)	G13270007
CUSTOMER P/N	
ISSUE DATE	Jan.6,2011
VERSION	D

APPROVED	PREPARED	QA
Brenda	Clane	Canthur
APPROVED BY	CUSTOMER:	AVL Status
Please return one copy with approval to PSE-TW		

PSE Technology Corporation

No.2, Tzu-Chiang 5th Rd, Chung Li Industrial Park, Chung Li City, Taoyuan County, Taiwan (R.O.C.)

TEL: 886-3-451-8888 FAX: 886-3-461-3865

http://www.saronix-ecera.com.tw

*RoHS Exception

*HF-Halogen Free

*REACH Compliant



*** A company of PERICOM Semiconductor Corporation ***

E0-R-4-014 Rev. E Page i

G13270007

VER. D

6-Jan-11

VERSION HISTORY

Version No.	Version Date	Customer Receipt Date	Supplier Receipt Date	Description	Notes
А	Mar.5,2010			Initial Release	
В	Mar.12,2010			Add Temperature Coefficient -0.035 ppm/°C ²	
С	Aug.19,2010			Changed Logo	
D	Jan.6,2011			Revised format	



E0-R-4-014 Rev. E

G13270007

VER. D

6-Jan-11

ELECTRICAL SPECIFICATIONS

SRe Part Number: G13270007

Parameters	Symbol	Specifications	Units	Notes
Nominal Frequency	Fn	32.768	KHz	
Mode of Oscillation	МО	Fundamental		+2° X-Cut
Load Capacitance	CL	12.5	pF	Typical
Calibration Tolerance		± 20	ppm	at 25℃ ± 5℃
Operating Temperature Range	TR	-10~60	$^{\circ}\!\mathbb{C}$	
Drive Level	DL	1	μ W	Max.
Equivalent Series Resistance	ESR	35	ΚΩ	Max.
Shunt Capacitance C0	C0	1.6	pF	Typical
Temperature Coefficient	K	-0.035	ppm/°C2	Typical
Aging		± 5	ppm	Max 1st year
Insulation Resistance		500	$M\Omega$	at DC 100V ± 15V

^{**}RoHS Complaint Product

Reliability (Mechanical and Environmental Endurance)

No.	Test Items	Test Method and Condition	Requirements
1	Vibration	(1) Vibration Frequency: 10 to 55Hz	Frequency Change: ±10ppm Max.
		(2) Vibration Amplitude: 1.5mm	Resistance Change: 5kohm Max.
		(3) Cycle Time: 1-2min(10-55-10Hz)	
		(4) Direction: X.Y.Z	
		(5) Duration: 2h/each direction	
2	Shock	3 Times free drop from 75cm height to hard wooden	Frequency Change: ±10ppm Max.
		board of thickness more than 30mm	Resistance Change: 5kohm Max.
3	Leakage	Put crystal units into a hermetic container and	Leakage: 1x10 ⁻ 8Pa·m1/s Max.
		Helium for 0.5-0.6Mpa, and keep it for 1h;	
		Check the leakage by a Helium leak detector	



E0-R-4-014 Rev. E Page 1

G13270007

VER. D

6-Jan-11

4	Lead Strength	The crystal lead with the 0.9kg(9N) power (keep it for	The crystal lead is not abnormity
	(DIP)	30s±5s) and bend the crystal lead 90° with 0.45kg	,
		power and two times	
		(which you want to bend should be more than	
		1.5mm from the case)	
5	High Temperature	The crystal units shall be put in somewhere for 2 hrs	Frequency Change: ±10ppm Max.
	Endurance	at temperature of 85°C±2°C, then keep it for 1 to 2 hrs	Resistance Change: 5kohm Max.
		under room temperature.	
6	Low Temperature	The crystal units shall be put in somewhere for 2 hrs	
	Endurance	at temperature of -25 $^\circ$ C, then keep it for 1 to 2 hrs	
		under room temperature.	
7	Humidity	The crystal units shall be put in somewhere at $40^{\circ}\mathrm{C}$	
	Endurance	in relative humidity of 90-95% for 48 hrs, then keep	
		it for one or two hours under room temperature.	
8	Temperature	Temperature shift from low(-40°ℂ) to high(100°ℂ, keep	
	Cycle	30 mins), satisfy high(100°C) to low(-40°C, keep	
		30 mins), then go up to room temperature for 5 cycles.	
9	Salt Spray Test	Put the crystal units in the salt spray room (salt	The appearance shall has no abnormity
		density: 5%) at the temperature of 35 $^$ C for 96 hrs.	and soldering is good.
		Then clean it with water and dry its surface.	Frequency Change: ±10ppm Max.
			Resistance Change: 5kohm Max.



E0-R-4-014 Rev. E Page 2

G13270007

VER. D

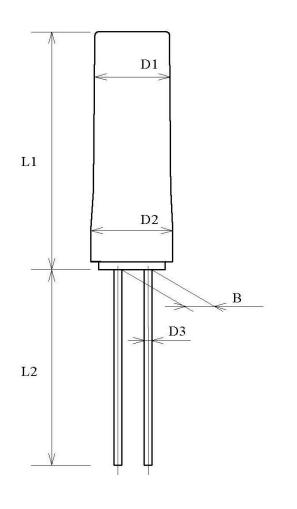
6-Jan-11

MARKING

32768

DIMENSIONS (Unit:mm)

L1	8.0±0.2	
L2	9.6±0.5	
D1	φ 3.0±0.1	
D2	φ 3.0±0.1	
D3	φ 0.32±0.05	
В	0.8±0.2	

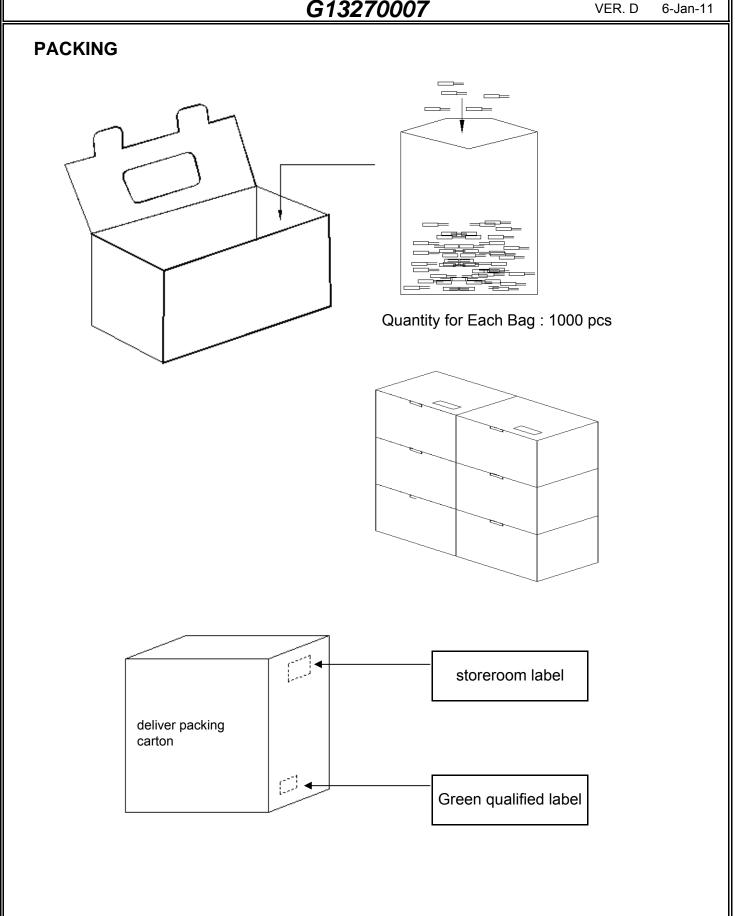




E0-R-4-014 Rev. E Page 3

G13270007

VER. D





E0-R-4-014 Rev. E Page 4